

PATENT

Attorney Docket :
33082 M 278

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

Applicant(s): Yasushi HAYASHIDA, et al.

International Application No.: PCT/JP2004/004383

International Filing Date: March 26, 2004

U.S. Serial No.: To Be Assigned

Group Art Unit: To Be Assigned

Filed: : Herewith

Examiner: To Be Assigned

For: SUBSTRATE PROCESSING SYSTEM, AND METHOD OF CONTROL
THEREFOR, CONTROL PROGRAM, AND STORAGE MEDIUM

INFORMATION DISCLOSURE STATEMENT

Commissioner for Patents
P.O. Box 1450
Alexandria, VA 22313-1450

Sir:

Pursuant to the duty of disclosure under 37 C.F.R. 1.56, Applicants are enclosing an Information Disclosure Citation Form (PTO-1449) which lists the documents noted in the specification and International Search Report being filed herewith. Copies of all non-U.S. cited documents are enclosed. On the enclosed PTO-1449, document AK is discussed in Applicants' specification. According to the Search Report, documents AA and AH are counterparts, documents AB and AK are counterparts, and documents AI and AJ are counterparts.

It is respectfully requested that the cited documents be considered by the Examiner in the above-identified patent application and that the cited documents be made officially of record therein. It is further requested that a listing of the same appear on the face of any patent which may issue from this application.

Respectfully submitted,
SMITH, GAMBRELL & RUSSELL, LLP

By:



Michael A. Makuch, Reg. No. 32,263
1850 M Street, N.W., Suite 800
Washington, D.C. 20036
Telephone: (202) 263-4300
Fax: (202) 263-4329

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FORM PTO-1449 INFORMATION DISCLOSURE STATEMENT	ATTY. DOCKET 33082M278	SERIAL NO. To Be Assigned
	APPLICANT: Yasushi Hayashida, et al.	
	FILING DATE Herewith	GROUP ART UNIT To Be Assigned

U.S. PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB- CLASS	FILING DATE, IF APPROPRIATE
	AA	5,687,085	11/11/97	Morimoto et al.			
	AB	2001/0048865	12/6/01	Tateyama et al.			
	AC						
	AD						
	AE						
	AF						
	AG						

FOREIGN PATENT DOCUMENTS

*Examiner's Initials		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB- CLASS	TRANSLATION YES NO	
	AH	08-153765	6/11/96	Japan			Abstract	
	AI	2002-506285	2/26/02	Japan			X	
	AJ	WO 99/45575	9/10/99	PCT				
	AK	2001-345241	12/14/01	Japan			Abstract	
	AL	11-045926	2/16/99	Japan			Abstract	
	AM	09-181143	7/11/97	Japan			Abstract	
	AN							
	AO							
	AP							

OTHER INFORMATION (Including Author, Title, Date, Pertinent Pages, Etc.)

	AQ	
	AR	
	AS	
	AT	

EXAMINER:

DATE CONSIDERED:

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.